	Searcn Notes					
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/041,084	BETZ ET AL.
Examiner	Art Unit
Daquan Zhao	2633

	SEAR	CHED	
Class	Subclass	Date	Examiner
386	52,4,45	9/18/2006	DZ
	1,125	9/18/2006	DZ
	126	9/18/2006	DZ

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	<u> </u>		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB (please see search note attached)	9/18/2006	DZ
please see search note for inventor name search	9/18/2006	DZ